CLAIMS

We claim:

axes.

- A monolithic integrated 3-axis accelerometer chip, comprising:

 a single crystal substrate, said single crystal substrate including at
 least one single crystal membrane layer portion, and
 a single sensor microstructure formed using said membrane layer,

 said sensor microstructure capacitively sensing acceleration in all three orthogonal
- 2. The accelerometer of claim 1, further comprising at least one electronic circuit formed on said on said chip, said electronic circuit communicably connected to said accelerometer.
- 3. The accelerometer of claim 1, wherein said electronic circuit includes at least one selected from the group consisting of a pre-amplifier, a demodulator, a low-pass filter, an A/D converter and a DSP.
- 4. The accelerometer of claim 1, wherein all components comprising said sensor microstructure utilize said membrane layer.
- 5. The accelerometer of claim 1, wherein said sensor microstructure comprises a plurality of comb finger sets including at least one comb finger set for motion sensing in each of said three orthogonal axes.
- 6. The accelerometer of claim 5, wherein said plurality of comb finger sets provides fully differential capacitive bridges for both x-sensing and y-sensing.

- 7. The accelerometer of claim 1, wherein said plurality of comb finger sets comprise a metal/dielectric composite thin film layer stack disposed on said membrane layer.
- 8. The accelerometer of claim 7, wherein said membrane layer beneath respective ones of said comb finger sets are electrically isolated from one another.
- 9. The accelerometer of claim 1, wherein said accelerometer includes a rigid frame disposed between structure for x-y sensing and structure for z sensing for decoupling x-y sensing from z-sensing.
- 10. The accelerometer of claim 9, wherein said structure for z-sensing is disposed inside said rigid frame, wherein said frame together with said z-sensing structure is an effective proof mass for said structure for x-y sensing.
- 11. The accelerometer of claim 9, wherein said structure for x-y sensing is disposed inside said frame, wherein said frame plus said x-y sensing structure is an effective proof mass for said z-sensing structure.

- 12. The accelerometer of claim 1, wherein said accelerometer includes structure for differential capacitive sensing in at least one of said three orthogonal axes.
- 13. The accelerometer of claim 1, wherein said accelerometer includes structure for differential capacitive sensing in all three of said orthogonal axes.
- 14. The accelerometer of claim 12, wherein said structure for differential capacitive sensing comprises a rotor disposed between two stators, said rotors and said stators formed from a metal/dielectric stack disposed on said membrane layer.
- 15. The accelerometer of claim 14, wherein said metal in said metal/dielectric stack portions are electrically isolated from said membrane layer.
- 16. The accelerometer of claim 14, wherein said metal in said metal/dielectric stacks is electrically connected to said membrane layer, said membrane layer comprising an electrode of said structure for differential capacitive sensing.
- 17. The accelerometer of claim 14, wherein said metal in said metal/dielectric stack is disposed in sidewalls of said metal/dielectric stack.
- 18. The accelerometer of claim 14, wherein a cross sectional area of said membrane layer is less than a cross sectional area of said metal/dielectric stack.
- 19. The accelerometer of claim 18, wherein a cross sectional area of said membrane layer proximate to an interface with said metal/dielectric stack is less than a nominal cross sectional area of said membrane layer.
- 20. The accelerometer of claim 1, wherein said membrane layer is less than 100 μm thick.